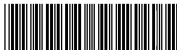


Search Notes**Application/Control No.**

10/537,755

Examiner

Seyed Azarian

Applicant(s)/Patent under Reexamination

NISHIMURA ET AL.

Art Unit

2624

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INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
INVENTOR SEARCH	6/15/2008	S.A
EAST SEARCH	6/15/2008	S.A
IEEE/NPL SEARCH	6/16/2008	S.A